

Measurement of reverse-bias capacitance of p-n junction diode

Objective: To measure the reverse-bias capacitance of p-n junction diode.

Background: Under reverse bias, the small signal model of a p-n junction is essentially a capacitance given by $C = A\epsilon / W$, A being the depletion layer area of the diode and W being the depletion layer width. As the reverse bias V_r increases, W increases, thus causing a decrease in C . Measurement of C as a function of V_r can be used to identify the type of junction and to calculate the doping density (N_D) in a p+n junction.

Purpose and method: The purpose of this experiment is to measure the small-signal capacitance C of a p-n junction at different values of the dc reverse bias V_r . We will do this by generating a voltage $v(t) = V_{dc} + V_{ac}(t)$ from a dc voltage (V_{dc}) and an ac voltage (V_{ac}), and then measuring the ac current through the diode when this $v(t)$ is applied across its terminals. For the first part, we will use a “summer” circuit, and for the second, we will use a current-to-voltage converter. Both of these circuits can be implemented using op-amps.

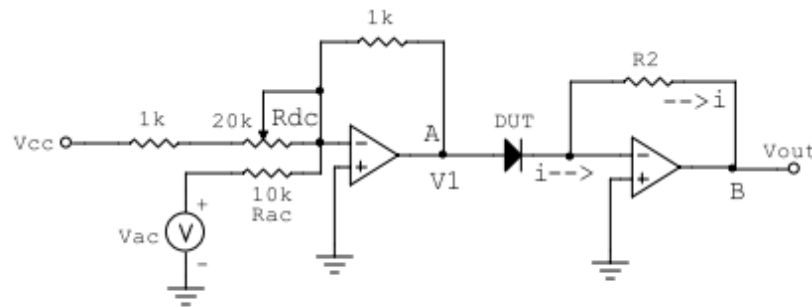


Figure 1

The complete circuit is shown in Fig.1. Show that the voltage V_1 is given by, $V_1 = -V_{cc} (1k\Omega / R_{dc}) - V_{ac} (1/10)$. The cathode (the 'n' side) of the diode is at 0V (why?). Thus V_1 is also the voltage across the diode. This voltage causes a current i (which consists of a small dc “leakage” current and an ac current) to flow through the diode as well as R_2 resulting in $V_{out} = -R_2 i$. By measuring the ac part of V_{out} and V_1 , we can calculate the small signal capacitance of the diode.

Experiment:

Use $\pm 15V$ for the Op-Amp supplies. Note that $+V_{cc}$ also serves to generate the dc bias for the diode (or else use a separate supply).

A) Testing:

B) Use $R_2 = 22K$. Disconnect R_{dc} as we want only the ac voltage for testing.

1) Use a resistor ($R = 10\text{K}$) as the "device under test" (DUT) instead of a diode. Apply a 1 KHz, 1V peak-to-peak sinusoidal signal (note that this is scaled down by a factor of 10, as seen earlier) and measure V_{out} . Calculate R from this measurement. It should be equal to 10 K.

2) Use a capacitor ($C = 1\text{nF}$) as DUT. Apply a 1V peak-to-peak sinusoidal voltage. Vary the frequency and observe its effect on V_{out} . Calculate C . It should be equal to 1nF.

B) Diode capacitance:

Use the base-collector junction of the n-p-n (BJT SL100) as the DUT (make sure the Junction is reverse biased). Connect R_{dc} as shown in Fig.1. Use $R_2 = 1\text{M}\Omega$, frequency = 25 to 60 KHz. Choose an appropriate frequency so that the output voltage is easily observable, but ensure that there is a 90° phase shift between input and output (why?). Apply a 2V peak-to-peak sinusoidal signal as input, which will result in a 200 mV p-p ac signal at V_1 . Observe V_{out} and verify that its amplitude varies as the dc bias across the diode is varied.

Measure the dc level and ac amplitude at nodes A and B respectively for $V_r = 1$ to 10V (in steps of 1V). Repeat for the base-emitter junction of BJT SL100, for $V_r = 1$ to 5V, in steps of 1V. (Again, make sure the junction is reverse-biased).